

Notice of References Cited

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Application/Control No.	Applicant(s)/F	Patent Under
09/655,402	Reexamination CHOI, SEUN	
Examiner '	Art Unit	
Stephen M. D'Agosta	2684	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,510,319	01-2003	Baum et al.	455/442
	В	US-5,946,622	08-1999	Bojeryd, Nils Johan	455/444
	С	US-5,917,811	06-1999	Weaver et al.	370/332
	D	US-6,266,529	07-2001	Chheda, Ashvin	455/436
	Е	US-5,353,332	10-1994	Raith et al.	455/455
	F	US-6,253,085	06-2001	Bender, Paul E.	455/442
	G	US-6,321,089	11-2001	Han, Jong Sun	455/438
	Η	US-6,487,191	11-2002	Kang et al.	370/342
	ı	US-6,512,925	01-2003	Chen et al.	455/442
	J	US-			
	К	US-			
	L	US-			•
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	EP0680160	04-1995	JP	Dohi et al.	H04B 7/005
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	v				
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	x				

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